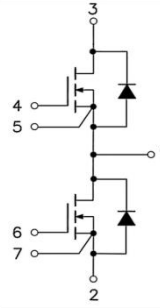


34mm Half Bridge SiC Module

Parameter	Value	Unit
V_{DS}	1200	V
I_D	300	A
$R_{DS(ON)}$	5.3	m Ω
Q_G	714	nC



Features:

- High Current Density
- Low Inductive Design
- Low Switching Losses
- High-frequency Operation
- Zero Turn-off Tail Current from MOSFET

Applications:

- High Power Converters
- Motor Drives
- UPS Systems

Absolute Maximum Ratings ($T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source Voltage	1200	V
V_{GS}	Gate-source Voltage	-10/+22	V
I_D	Drain Current (continuous)	300	A
I_{DM}	Drain Current (pulsed)	600	A
$T_{op}; T_{stg}$	Operating and Storage Temperature Range	-40 to +150	$^\circ\text{C}$
T_J	Junction Temperature	175	$^\circ\text{C}$
L_{Stray}	Stray Inductance	30	nH
V_{isol}	Isolation Test Voltage (f=50Hz; t=1min)	3.0	kV
M	Terminal Connection Torque (M5)	2.5-5.0	Nm
W	Weight	160	g

MOSFET Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
Static characteristics (at $T_C=25^\circ\text{C}$ unless otherwise specified)						
B_{VDS}	Drain-source Breakdown Voltage	1200	-	-	V	$V_{GS}=0\text{V}$
I_{DSS}	Zero Gate Voltage Drain Current	-	-	300	μA	$V_{DS}=1200\text{V}; V_{GS}=0\text{V}$
I_{GSS}	Gate-body Leakage Current	-	-	3	μA	$V_{GS}=-10/+20\text{V}; V_{DS}=0\text{V}$
$V_{GS(th)}$	Gate Threshold Voltage	2	-	4	V	$V_{DS}=V_{GS}; I_D=30\text{mA}$
$R_{DS(on)}$	Static Drain-source on Resistance	-	5.3	7.3	m Ω	$V_{GS}=18\text{V}; I_D=150\text{A}; T_J=25^\circ\text{C}$
$V_{GS(on)}$	Recommended Turn-on Voltage	-	18	-	V	Static
$V_{GS(off)}$	Recommended Turn-off Voltage	-	-5	-	V	

R_G	Gate Resistance	-	1.1	-	Ω	$V_{GS}=0V; f=1MHz$
Dynamic characteristics (at $T_C=25^\circ C$ unless otherwise specified)						
C_{iss}	Input Capacitance	-	20.6	-	nF	$V_{DS}=1000V; f=1MHz;$ $V_{AC}=25mV$
C_{oss}	Output Capacitance	-	0.86	-		
C_{riss}	Reverse Transfer Capacitance	-	39	-	pF	
E_{on}	Turn-on Switching Energy	-	22.7	-	mJ	$V_{DD}=900V; V_{GS}=-5/+18V;$ $I_D=300A; Load=100\mu H$
E_{off}	Turn-off Switching Energy	-	16.9	-		
Q_{GS}	Gate-Source Charge	-	230.0	-	nC	$V_{DD}=800V; V_{GS}=-5/+18V;$ $I_D=150A$
Q_{GD}	Gate-drain Charge	-	234.9	-		
Q_G	Total Gate Charge	-	714	-		
$t_{d(on)}$	Turn-on Delay Time	-	101.4	-	ns	$V_{DD}=900V; V_{GS}=-5/+18V;$ $I_D=300A; R_{G(ext)}=5\Omega$
t_r	Rise Time	-	93.0	-		
$t_{d(off)}$	Turn-off Delay Time	-	256.1	-		
t_f	Fall Time	-	54.3	-		
$R_{th(j-c)}$	Thermal Resistance, Junction-to- heat sink	-	0.14	-	$^\circ C/W$	-

Body Diode Characteristics ($T_J=25^\circ C$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
V_{FSD}	Forward Voltage	-	-	6	V	$V_{GS}=0V; I_F=150A$
I_S	Continuous Diode Forward Current	-	150	-	A	$V_{GS}=0V; T_C=25^\circ C$
T_{RR}	Reverse Recovery Time	-	32.8	-	ns	$V_{GS}=-5/+18V; I_F=300A;$ $V_R=900V$
Q_{RR}	Reverse Recovery Charge	-	678	-	nC	
I_{RRM}	Peak Reverse Recovery Current	-	51.5	-	A	

Typical Characteristics

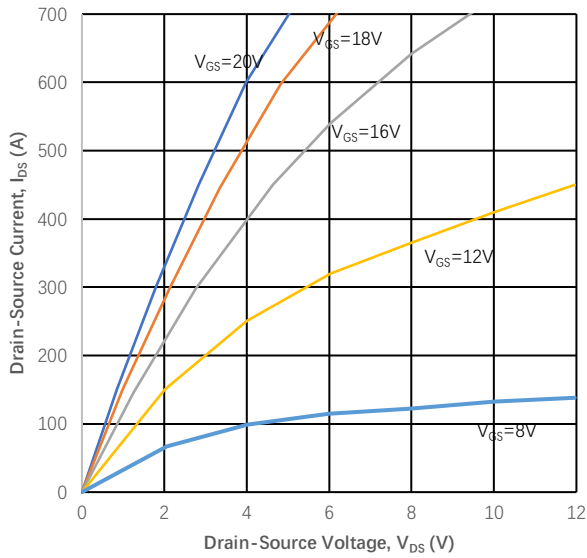


Figure 1
 Output Characteristics ($T_J=25\text{ }^\circ\text{C}$)

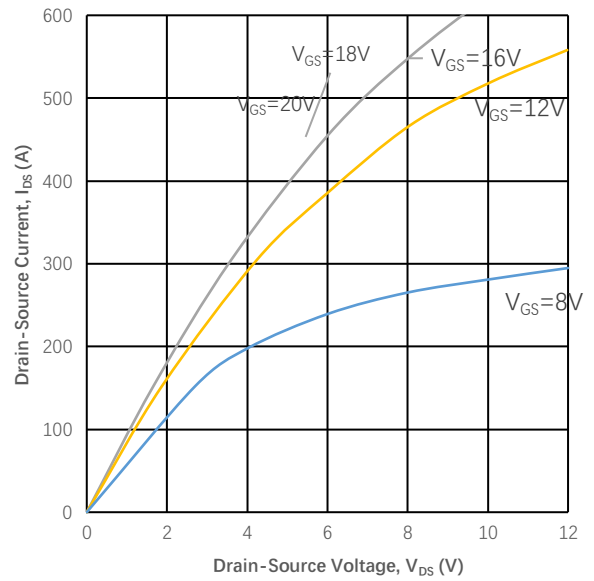


Figure 2
 Typical Output Characteristics ($T_J=150\text{ }^\circ\text{C}$)

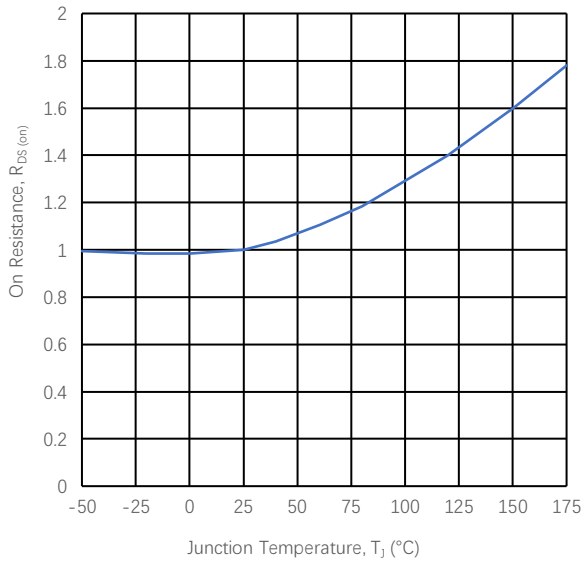


Figure 3
 Normalized on-resistance vs. T_J

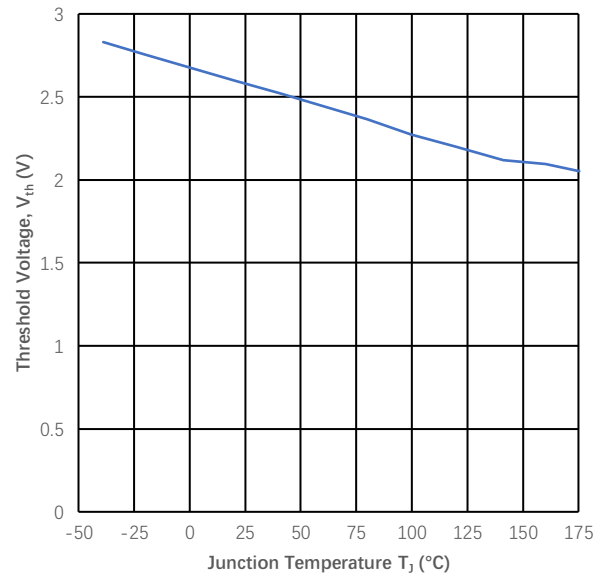


Figure 4
 Threshold Voltage vs. Temperature

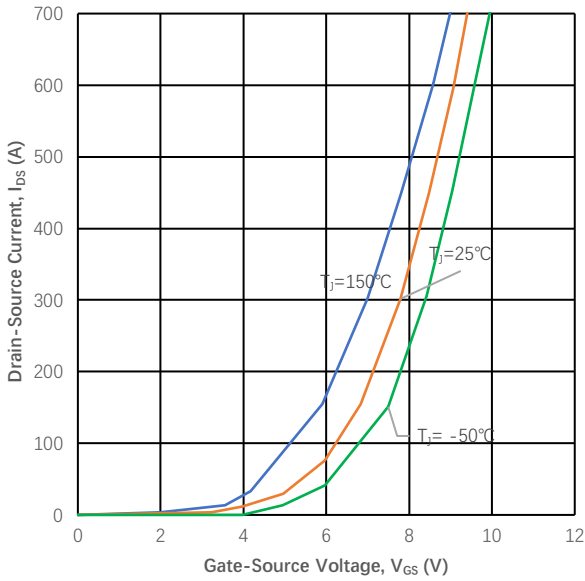


Figure 5
 Transfer Characteristic for Various T_j

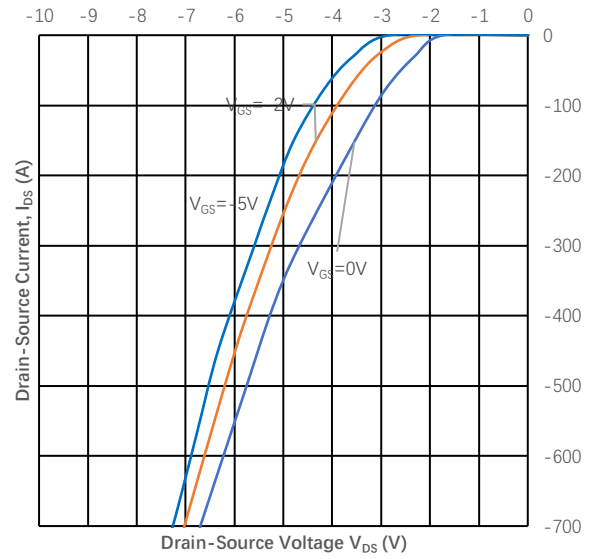


Figure 6
 Body Diode Characteristic

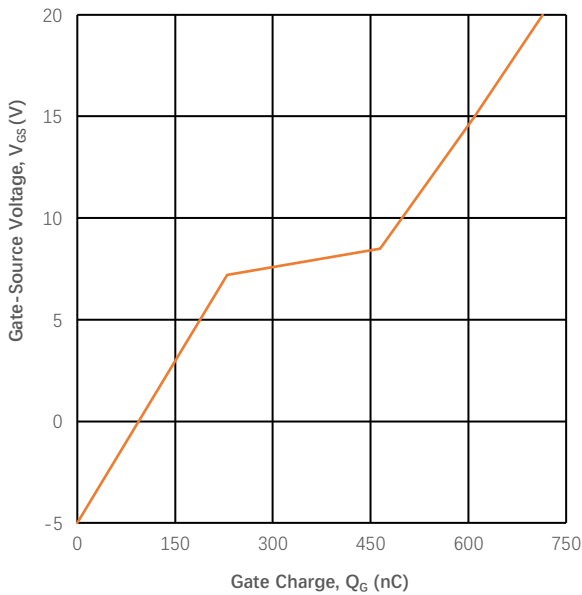


Figure 7
 Gate Charge Characteristics

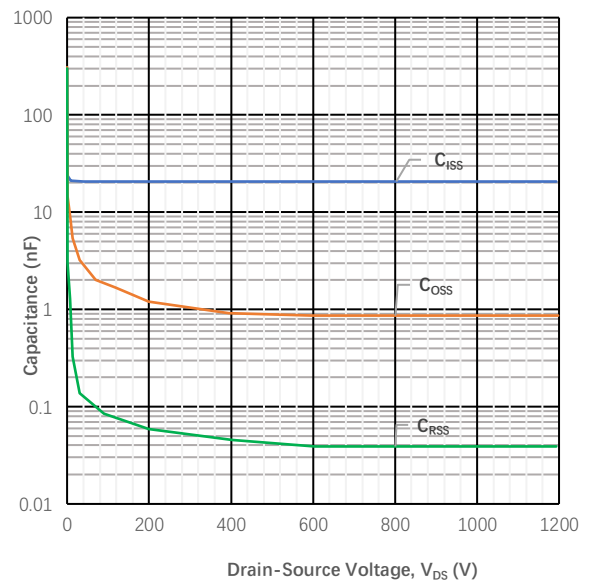


Figure 8
 Capacitances vs. V_{DS}

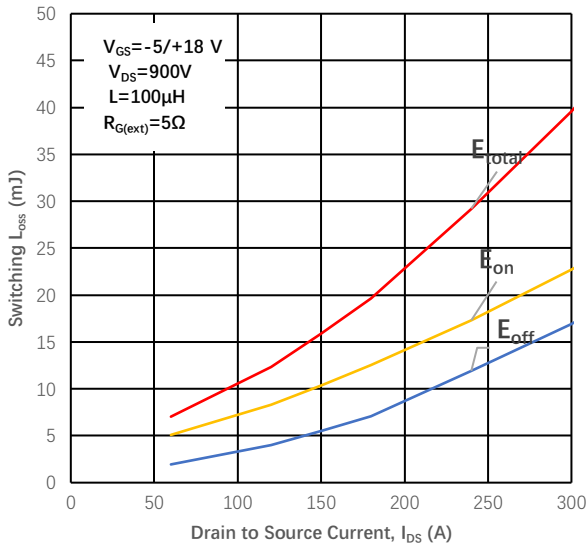


Figure 9

Inductive Switching Energy vs. Drain Current

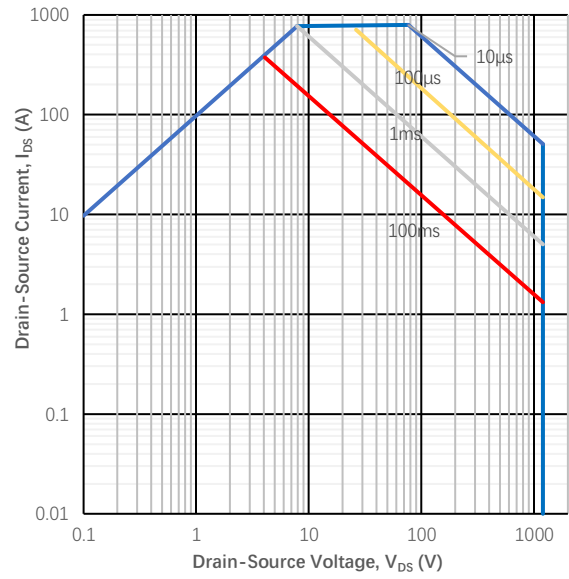
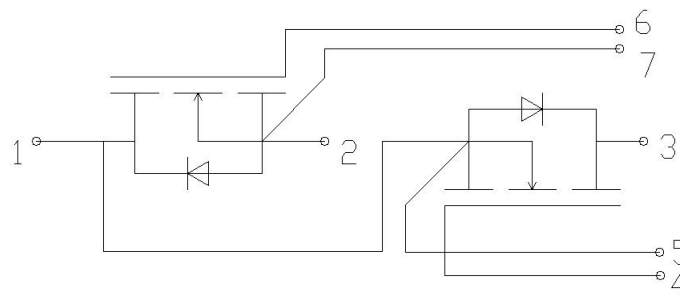


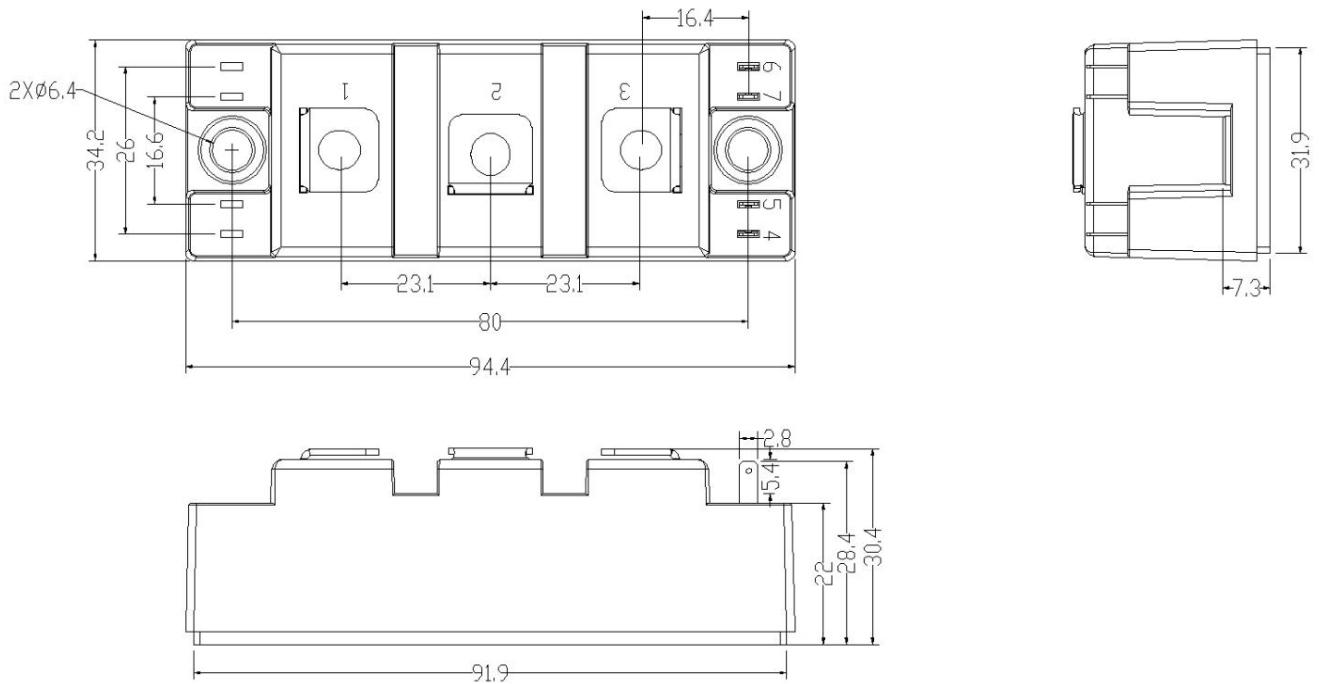
Figure 10

Safe Operating Area

Circuit Diagram



Package Outlines(Unit: mm):



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